
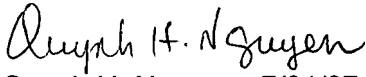


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/801,872	MEEK ET AL.	
	Examiner	Art Unit	
	Quynh H. Nguyen	2614	

ISSUE CLASSIFICATION											
ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
379		196		379	211.01	211.02	201.01	127.01	142.05	93.03	114.25
INTERNATIONAL CLASSIFICATION											
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(Assistant Examiner) (Date)		 Quynh H. Nguyen 7/31/07 (Primary Examiner) (Date)	Total Claims Allowed: 17	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 15	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input checked="" type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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